Approved For Release 2008/03/11: CIA-RDP80-00810A005900940005-2 CLASSIFICATION SECRET REPORT CENTRAL INTELLIGENCE AGENCY INFORMATION REPORT CD NO. 25X1 DATE DISTR. 23 February 1955 COUNTRY East Germany NO. OF PAGES 6 SUBJECT Manufacture of Silicon Diodes at VEB Werk fuer Bauelemente der Nachrichtentechnik "Carl von Ossietzky", Teltow NO. OF ENCLS. PLACE (LISTED BELOW) 25X1 **ACQUIRED** SUPPLEMENT TO DATE OF REPORT NO. INFO. 25X1 THIS IS UNEVALUATED INFORMATION 794, OF THE U.S. CODE, AS AMENDED. ITS TRANSMISSION OF OF ITS CONTENTS TO OR RECEIPT BY AN UNAUTHORIZED VEB Werk fuer Bauelemente der Nachrichtentechnik "Carl von Ossietzky" (form 25X1

Dralowid), in Teltow, on the significance of silicon crystal diodes:

"This firm calls semi-conductor diodes (Halbleiterdioden) a circuit element whose resistance is dependent upon the direction of the current and which has two contacts (a dipole in the meaning of circuit theory). It is used in circuits of the weak-current technology, as, for instance, in takecommunications technology, measurement technology and circuit technology. The device is designated by the name silicon diode. When the rapid development of radar technology extended to the fields of decimeter and centimeter waves, crystal diodes obtained increasing significance and they now are even starting to displace electron tubes in numerous fields of application. The reasons for this development are obvious. Crystal diodes have important advantages as compared with tube diodes and surface rectifien volt, they have higher conductivity than tube of heating and therefore do not contribute to di (Brummstoerungen). In addition, they are largely independent the frequency because of their small self-capacity and because of the electron qualities of silicon. The physical qualities of diodes, such as their very small dimensions, small weight and the fact that seekets and vacuum are unnecessary, make it possible to build the diodes into the cruit in a very easy way. The current-voltage characteristics passet through zero and is almost linear for small inversed voltages, and approximately quadratic in the pass area" (Durchlassbereich). Silicon diodes are now being used increasingly as rectifiers for alternating voltage and as mixer diones (Mischdioden) for highest s which they have in special frequencies. In addition to numerous appli rashort wave and centimeter lodes are particularly useful ennlinie) is not linear The fact that the characteristi cuits for the purpose of makes it possible to use diodes in many special measurement . " recomposit

2. The following are general indications also contained in the directive on the

25X1

	CLASSIFICATION	SECRET	
STATE	X NAVY X NSRB	DISTRIBUTION	OSI EV X
ARMY	X Approved For Pologoe	0009/03/11 · CIA BDD90 00910	1 ORK EV X

SECRET

"Two metal caps are welded upon a ceramic shell. One cap houses the antielectrode of the silicon crystal, which consists of an "S"-shaped molybdenum wire of 90-micron diameter. The other cap has a thread/which holds the screw electrode upon which the silicon crystal is welded. These diodes, thus, are point-contact diodes causing rectification through the contact between metal point and semi-conductor crystal."

- 3. The firm puts out two types of diodes called mixer diodes (Misch des (Richtdioden); in abbreviation, MD and RD. nanufactured in four different construction form arawings of the four types, with dimensions indicated).
- 4. The following is the German nomenclature for the characteristic data of the diodes as used in the annexed table (Annex 3), which lists the characteristic data of all diodes manufactured by the Dralowid firm. The numbers in brackets appearing in the following sub-paragraphs are keyed to the numbers appearing in the various headings on Annex 3.
 - a. The direction of the current sistance is called <u>Durchlass-</u>
 michtung. The current is called strom (L).
 - b. The direction of the current wit seems stance is called "Sperrrichtung".

 The current in this case is call the strom (2).
 - c. Both <u>Durchlasstrom</u> and <u>Sperrstrom</u> are currents in <u>Durchlassrichtung</u> which flowlaw at a given direct voltage.
 - d. The Widerstandsverhaeltnis
 Durchlasswiderstand at the



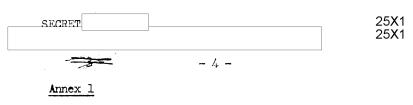
- g. The mechanical <u>Schuettelfestigkeit</u> (6) is expressed in multiples of the gravitation constant The diodes put out by Dralowid withstand shaking with a sinusoidal acceleration of maximum 5g.
- h. The <u>Temperaturbereich</u> (7) of the diodes is the temperat in which a diode can be stored or operated without permanent charqualities.
- i. The Temperaturkoeffizient (8) pertains to the changes of the current at the given voltage and to the linear temperature dependency of <u>Durchlasstrom</u> and <u>Sperrstrom</u>. It is expressed in percent per centigrade.
- j. The Nennfrequenz (9 of the Bichtstrom i
- k. The <u>Mischdaempfung</u> (10) is determined by the relation between the high frequency input and the medium frequency output. It is expressed in decibels (db).

1	0=1//
ECRET	25 X 1

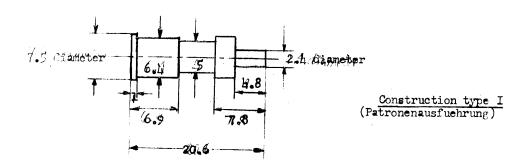
- 2 -

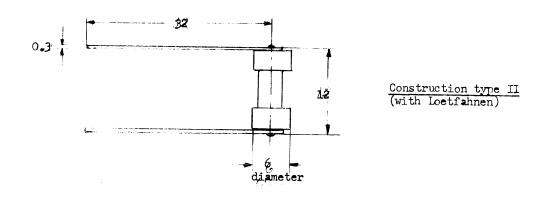
	SECRET								
	- 3 -	25X1							
1.	Comment. The following are English equivalents for the German terms used in paragraph 4:	25 X 1							
	Durchlassrichtung - low resistance direction Durchlasstrom - low resistance current Sperrichtung - high resistance direction Sperrstrom - high resistance current Durchlasswiderstand - low resistance resistor Sperrwiderstand - high resistance resistor Widerstandsverhaeltnis - resistance ratio maximale Impulsbeanspruchung - maximum impulse load statische Eigenkapazitaet - static self-capacity Kapazitaet gegen Masse - capacity in relation to the whole Schuettelfestigkeit - capacity to withstand shaking Temperaturbereich - temperature range Temperaturkoeffizient - temperature coefficient Nennfrequenz - rated frequency Richtstrom - rectified current Mischdaempfung - mixed attenuation								
		25 X 1							

SECRET

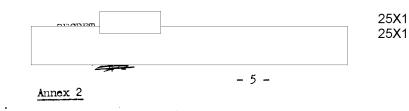


(All dimensions in millimeters)

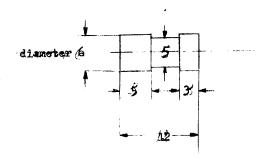




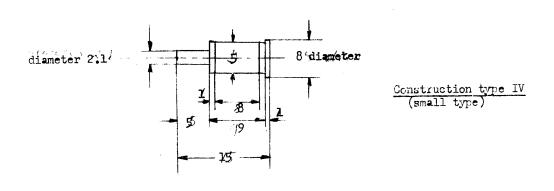
25X1 25X1



(All dimensions in millimeters)



Construction type III (for special purposes)



SECRET-

25X1 ∠5∧1

			• •		8/03/11: CIA-RDP ALOWID SILICON 1		0940005-2		- 25X
TYPE	(L) in mA at +0.5V	(2) in micro-A at -0.5V	(3) at -0.5V	([]]) (10-7W)	· (5) pf	(6) g	(7) Temperaturede(C) storage operation	(8) (9) C+10 to +60 GHz Centigrades %/Temptigratures at +0.5V at-0.5V	(1C)
MD 1	equal or more	•	equal or more than 5	0.3	less than l	equal or more than 5	-40;+60 -20;+50		٠.
MD 13	equal or more than 2	*	equal or more than 10	0.3	less than 1	equal or more than 5	-40;+60 -20;+50	10	eqwal or less
MD 2	equal or more than 0.12 at 70mV	equal or less than 60 at -70mV	s equal or more than 2 at +70m V	0.3	less than 1	equal or more than 5	-40;+60 -20;+50		a
RD 1	equal or more	equal or less	equal or more than 10	1	less than l	equal or more than 5	-40;+60 -20;+60	equal or equal less of less than 1 than 5	. Shoret CS-56635
RD 2	equal or more than 0.50	equal or less than 20	s equal or more than 25	1	less than 1	equal or more than 5	-40;+60 -20;+50	equal equal or less than 1 than 5	RET
RD 3	equal or more than 0.50	equal or less than 7	s equal or more than 35	1	less than 1	equal or more than 5	-40;+60 -20;+50	equal equal or less than 1 than 5	1 %
RD 4	equal or more than 0.10	equalr or les	ss equal or more than 50	1	lėss than l	equal or more than 5	-40;+60 -20;+50	equal equal or less than 1 than 5	\ , .

Comment: All diodes listed above are fabricated in four types of construction as shown in annexes 1 and 2.

SECRET

25X1 25X1

CENTRAL INTELLIGENCE AGENCY 25X1 CD NO. COUNTRY DATE DISTR Germeny CAN TENUTY TO THE ferming our of Shilten Diodes of VEB Werk foer de legente der Nechrichtentechn**ik** arr von Ossietzky", feitow PLACT 25X1 **ACQUIRED** DATE OF INFC. UATED: INFORMATION VEB Werk fuer Bauelemente der Nachrichtentechnik karl von Vssietzky" (formerly 25X1 Dralowid), in Teltow, on the signal canon of sil "This firm calls semi-conductor diodes (Halbleiterdioden) a circuit eleg whose resistance is dependent upon the direction of the current and which two contacts (a dipole in the meaning of circuit theory). It is used in circuits of the weak-current technology, and for instance, in telecommunications technology, measurement technology and circuit technology. The device is designated by the name silicon diode. When the rapid development of radial technology are standard to the capital development of radial technology. technology extended to the fields of decimeter and centimeter waves, cry diodes obtained increasing significance and they now are even starting displace electron tubes in numerous fields of application. The reasons this development are obvious. Crystal diedes have important advantages a compared with tube diodes and surface rechifiers. With a few tenths of volt, they have higher conductivity than tube diodes; furthermore they do a heating and therefore do not contribute to disturbances caused by noise (Brummstoerungen). In addition, they are largely independent of frequency (Brummstoerungen). In addition, they are largely independent of frequent because of their small self-capacity, and because of their small self-capacity, and because of the couriest quality of silicon. The physical relities of clodes, such as their very small distinct, small weight and the decit-they scale and facuum are unnecessary, it possible to build the diction into the circuit fire a very casy way. The current-voltage characteristics page about the area and it limost linear the current in the course of the cou current-voltage characteristics of the pass area small inversed toltage; inches and a manufacture in the pass area small inversed toltage; inches and a manufacture with the voltage and a manufacture with the voltage and a manufacture with the pass area small inverse in the pass lmost linear for frequencies. In addition to numerous applications which they have in special fields, the diodes are particularly desirain filtrashort wave and centime tiones are particular legislation of treshort wave and centimeter. The fart that the characteristic line (Kennline) is not linear the purpose of makes it possib**le to** ucasurement 2. The following are general and construction of diodes by the directive on the CLASSIFICATIO 25X1 F X HOVY DISTRIBUTION STATE NSRE

Approved For Release 2008/03/11: CIA-RDP80-00810A005900940005-2

- 2 -

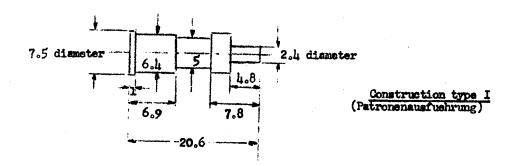
"Two metal caps are welded upon a ceramic shell. One cap houses the antielectrode of the silicon crystal, which consists of an "S"-shaped molybdenum wire of 90-micron diameter. The other cap has a thread which holds the screw electrode upon which the silicon crystal is welded. These diodes, thus, are point-contact diodes causing rectification through the contact between metal point and semi-conductor crystal."

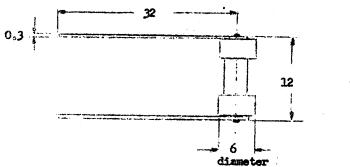
- 3. The firm puts out two types of diodes called mixer diodes (Mischdioden) and directional diodes (Richtdioden); in abbreviation, MD and RD. Each type is manufactured in four different construction forms. (See Annexes 1 and 2 for drawings of the four types, with dimensions indicated).
- 4. The following is the German nomenclature for the characteristic data of the diodes as used in the annexed table (Annex 3), which lists the characteristic data of all diodes manufactured by the Dralowid firm. The numbers in brackets appearing in the following sub-paragraphs are keyed to the numbers appearing in the various headings on Annex 3.
 - a. The direction of the current with low resistance is called <u>Durchlass-</u>
 michtung. The current is called <u>Durchlasstrom</u> (1).
 - b. The direction of the current with high resistance is called <u>Sperrrichtung</u>. The current in this case is called <u>Sperrestrom</u> (2).
 - c. Both <u>Durchlasstrom</u> and <u>Sperrstrom</u> are currents in <u>Durchlassrichtung</u> which flow at a given direct voltage.
 - d. The Widerstandsverhaeltnis (3) is the ratio between the Sperrwiderstand and the Durchlasswiderstand at the same absolute voltage value.
 - e. The maximale Impulsbeanspruchung (4) expressed in watts is the average value of the impulse performance during a second.
 - f. The statische Eigenkapazitaet (5) is mainly composed of the capacity of the cap and the "Kapazitaet gegen Masse".
 - g. The mechanical <u>Schuettelfestickeit</u> (6) is expressed in multiples of the gravitation constant g. The diodes put out by Dralowid withstand shaking with a sinusoidal acceleration of maximum 5g.
 - h. The Temperaturbereich (7) of the diodes is the temperature range in which a diode can be stored or operated without permanent change of its electric qualities.
 - i. The Temperaturkoeffizient (8) pertains to the changes of the current at the given voltage and to the linear temperature dependency of <u>Durchlasstrom</u> and <u>Sparrstrom</u>. It is expressed in percent per centigrade.
 - j. The Nonnfrequenz (9) is the maximum value of frequency up to which a decrease of the Richtstrom is unessential.
 - k. The <u>Mischdaempfung</u> (10) is determined by the relation between the high frequency input and the medium frequency output. It is expressed in decibels (db).

	SECRET - 3 -	25X1
1.	Comment. The following are English equivalents for the German terms used in paragraph 4:	25X1
	Durchlassrichtung - low resistance direction Durchlasstrom - low resistance current Sperrichtung - high resistance current Durchlasswiderstand - low resistance resistor Sperrwiderstand - high resistance resistor Sperrwiderstand - high resistance resistor Widerstandsverhaeltnis - resistance ratio maximale Impulsbeanspruchung - maximum impulse load statische Eigenkapazitaet - static self-capacity Kapazitaet gegen Masse - capacity in relation to the whole Schuettelfestigkeit - capacity to withstand shaking Temperaturbereich - temperature range Temperaturkoeffizient - temperature coefficient Nennfrequens - rated frequency Richtstrom - rectified current Mischdaempfung - mixed attenuation	•
		25X1



Annex 1
(All dimensions in millimeters)





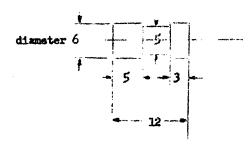
Construction type II (with Loetfahnen)

25X1

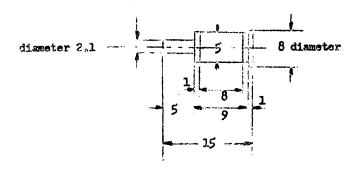
SECRET

Annex 2

(All dimensions in millimeters)



Construction type III (for special purposes)



Construction type IV (small type)

Approved For Release 2008/03/11: CIA-RDP80-00810A005900940005-2 CHARACTERISTIC DATA OF DRALOWID SILICON DIOLES 1/

			CHARACITATION	DALK OF DE	THEOWED SILL	LOOM D	1/						
TYPE	(I) ::n'mA at +0.5V	(2) in micro-A at -0.5V	(3) at -0.5V	(4) (20-7W)	(5) 75)	(€) \$	Temper	7) ature (C) operation	%/Temper	de	(10) db	
MD 1	equal or more	equal or less than 200	equal or more than 5	0.3	less than		equal or more than 5	-40;+60	-20;+50			-	
MD 13	equal or more than 2	equal or . less than 200	equal or more than 10	0.3	less than		equal or more than 5	-40;+60	-20;+50		10	equal or le	es
MD 2	equal or more than 0.12 at 70mV	equal or les than 60 at -70mV	s equal or more than 2 at -70mV	0.3	less than		equal or more than 5	-40;+60	-20;+50			25	5X1
RD 1	equal or more than 1	equal or les than 100	equal or more s than 10	1	less than		equal or more than 5	-40;+60	-20;+60	equal or less than 1	equal or less than 5		SECRET
RD 2	equal or more than 0.50	equal or les than 20	s equal or more than 25	1	less than		equal or more than 5	-40;+60	-20;+50	equal or less than 1	equal or less than 5		RET
RD }	equal or more than 0.50	equal or les than 7	s equal or more than 35	1	less tha		equal or more than 5	-40;+60	-20;+50	equal or less	equal or less than 5	ر م	
RD 4	equal or more than 0.10	equal or le	ss equal or more than 50	1	less tha		equal or more than 5	-40;+60	-20;+50	equal or less than 1	equal or less than 5	ŧ	

Comment: All diodes listed above are fabricated in four types of construction as shown in annexes 1 and 2.